

<b>Notice of References Cited</b>	Application/Control No. 10/761,918	Applicant(s)/Patent Under Reexamination ATWATER ET AL.	
	Examiner DuyVu n. Deo	Art Unit 1765	Page 1 of 1

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*	B	US-7,019,339	03-2006	Atwater et al.	257/184
*	C	US-2005/0142879	06-2005	Atwater et al.	438/689
*	D	US-2005/0085049	04-2005	Atwater et al.	438/455
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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